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		FILING DATE July 21, 2003	EXAMINER Unknown

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JP</i>	AA	5,900,637	05/04/1999	Smith			05/30/1997
<i>JP</i>	AB	5,263,073	11/16/1993	Feldman			12/20/1990
<i>JP</i>	AC	6,133,986	10/17/2000	Johnson			12/20/1997
<i>JP</i>	AD	2003/0123040	07/03/2003	Almogly			11/07/2002
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AG						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
<i>JP</i>	AH	"Sharper images by focusing soft X-rays with photon sieves," Kipp et al. <i>Nature</i> . November 2001. Vol. 414.
<i>JP</i>	AI	"Zone plate for arbitrarily high focal depth," Ojeda-Castaneda et al. <i>Applied Optics</i> . March 1990. Vol. 29, No. 7.
	AJ	
	AK	
	AL	

EXAMINER

Jack Berman

DATE CONSIDERED

1/25/05

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.